

<b>STN</b>	<b>Skúšobné metódy pre elektrotechnické materiály, dosky s plošnými spojmi a iné spájacie štruktúry a zostavy. Časť 5-4: Všeobecné skúšobné metódy pre materiály a zostavy. Spájky a drôtové elektródy pre dosky s plošnými spojmi.</b>	<b>STN EN 61189-5-4</b>
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Test methods for electrical materials, printed boards and other interconnection structures and assemblies - Part 5-4: General test methods for materials and assemblies - Solder alloys and fluxed and non-fluxed solid wire for printed board assemblies

Táto norma obsahuje anglickú verziu európskej normy.  
This standard includes the English version of the European Standard.

Táto norma bola oznámená vo Vestníku ÚNMS SR č. 07/15

Obsahuje: EN 61189-5-4:2015, IEC 61189-5-4:2015

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Úrad pre normalizáciu, metrológiu a skúšobníctvo SR, 2015

Podľa zákona č. 264/1999 Z. z. v znení neskorších predpisov sa môžu slovenské technické normy rozmnrožovať a rozširovať iba so súhlasom Úradu pre normalizáciu, metrológiu a skúšobníctvo SR.

**EUROPEAN STANDARD**  
**NORME EUROPÉENNE**  
**EUROPÄISCHE NORM**

**EN 61189-5-4**

March 2015

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## English Version

**Test methods for electrical materials, printed boards and other interconnection structures and assemblies - Part 5-4: General test methods for materials and assemblies - Solder alloys and fluxed and non-fluxed solid wire for printed board assemblies  
(IEC 61189-5-4:2015)**

Méthodes d'essai pour les matériaux électriques, les cartes imprimées et autres structures d'interconnexion et ensembles - Partie 5-4: Méthodes d'essai générales pour les matériaux et les assemblages - Alliages à braser et brasages solides fluxés et non fluxés pour les assemblages de cartes imprimées  
(IEC 61189-5-4:2015)

Prüfverfahren für Elektromaterialien, Leiterplatten und andere Verbindungsstrukturen und Baugruppen - Teil 5-4: Allgemeine Prüfverfahren für Materialien und Baugruppen - Lotlegierungen und Lotdraht mit und ohne Flussmittel für bestückte Leiterplatten  
(IEC 61189-5-4:2015)

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European Committee for Electrotechnical Standardization  
Comité Européen de Normalisation Electrotechnique  
Europäisches Komitee für Elektrotechnische Normung

**CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels**

## Foreword

The text of document 91/1212/FDIS, future edition 1 of IEC 61189-5-4, prepared by IEC/TC 91 "Electronics assembly technology" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 61189-5-4:2015.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2015-11-12
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2018-02-12

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## Endorsement notice

The text of the International Standard IEC 61189-5-4:2015 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60068-2-20	NOTE	Harmonized as EN 60068-2-20.
IEC 61189-1	NOTE	Harmonized as EN 61189-1.
IEC 61189-2:2006	NOTE	Harmonized as EN 61189-2:2006 (not modified).
IEC 61189-3:2007	NOTE	Harmonized as EN 61189-3:2008 (not modified).
IEC 61190-1-1	NOTE	Harmonized as EN 61190-1-1.
IEC 61190-1-2	NOTE	Harmonized as EN 61190-1-2.
IEC 61249-2-7	NOTE	Harmonized as EN 61249-2-7.
IEC 62137:2004	NOTE	Harmonized as EN 62137:2004 (not modified).
ISO 9001	NOTE	Harmonized as EN ISO 9001.
ISO 9455-2	NOTE	Harmonized as EN ISO 9455-2.

## Annex ZA

(normative)

### **Normative references to international publications with their corresponding European publications**

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here:  
[www.cenelec.eu](http://www.cenelec.eu)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61189-5	-	Test methods for electrical materials, interconnection structures and assemblies - Part 5: Test methods for printed board assemblies	EN 61189-5	-
IEC 61189-6	-	Test methods for electrical materials, interconnection structures and assemblies - Part 6: Test methods for materials used in manufacturing electronic assemblies	EN 61189-6	-
IEC 61190-1-3	-	Attachment materials for electronic assembly - Part 1-3: Requirements for electronic grade solder alloys and fluxed and non-fluxed solid solders for electronic soldering applications	EN 61190-1-3	-



# INTERNATIONAL STANDARD

## NORME INTERNATIONALE

**Test methods for electrical materials, printed boards and other interconnection structures and assemblies –**

**Part 5-4: General test methods for materials and assemblies – Solder alloys and fluxed and non-fluxed solid wire for printed board assemblies**

**Méthodes d'essai pour les matériaux électriques, les cartes imprimées et autres structures d'interconnexion et ensembles –**

**Partie 5-4: Méthodes d'essai générales pour les matériaux et les assemblages – Alliages à braser et brasages solides fluxés et non fluxés pour les assemblages de cartes imprimées**







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## CONTENTS

FOREWORD.....	4
INTRODUCTION.....	6
1 Scope .....	7
2 Normative references .....	7
3 Accuracy, precision and resolution .....	7
3.1 General.....	7
3.2 Accuracy.....	8
3.3 Precision.....	8
3.4 Resolution .....	9
3.5 Report.....	9
3.6 Student's <i>t</i> distribution .....	9
3.7 Suggested uncertainty limits .....	10
4 C: Chemical test methods .....	11
4.1 Test 5-4C01: Determination of the percentage of flux on/in flux-coated and/or flux-cored solder .....	11
4.1.1 Object.....	11
4.1.2 Test specimen .....	11
4.1.3 Apparatus .....	11
4.1.4 Test procedure .....	11
4.2 Test 5-4CXX .....	12
5 X: Miscellaneous test methods .....	12
5.1 Test 5-4X01: Spread test, extracted cored wires or preforms .....	12
5.1.1 Object.....	12
5.1.2 Method A .....	12
5.1.3 Method B .....	13
5.1.4 Additional information .....	15
5.2 Test 5-4X02: Spitting test of flux-cored wire solder .....	15
5.2.1 Object.....	15
5.2.2 Method A .....	15
5.2.3 Method B .....	16
5.2.4 Additional information .....	19
5.3 Test 5-4X03: Solder pool test.....	20
5.3.1 Object.....	20
5.3.2 Test specimen .....	20
5.3.3 Apparatus and reagents .....	20
5.3.4 Test procedure .....	20
5.3.5 Evaluation .....	21
5.3.6 Additional information .....	21
Bibliography.....	22
Figure 1 – Test apparatus for spitting test.....	16
Figure 2 – Test apparatus for spitting test, method B .....	18
Figure 3 – Collecting paper with printed concentric circles with 1 cm pitch .....	19

Table 1 – Student's <i>t</i> distribution.....	10
Table 2 – Typical spread areas defined in mm <sup>2</sup> .....	13
Table 3 – Example of a test report – Spitting of flux-cored wire.....	19

## INTERNATIONAL ELECTROTECHNICAL COMMISSION

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**TEST METHODS FOR ELECTRICAL MATERIALS,  
PRINTED BOARDS AND OTHER INTERCONNECTION  
STRUCTURES AND ASSEMBLIES –**

**Part 5-4: General test methods for materials and assemblies –  
Solder alloys and fluxed and non-fluxed solid wire for  
printed board assemblies**

**FOREWORD**

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 61189-5-4 has been prepared by IEC technical committee 91: Electronics assembly technology.

The text of this standard is based on the following documents:

FDIS	Report on voting
91/1212/FDIS	91/1225/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

This International Standard is used in conjunction with IEC 61189-1:1997, IEC 61189-2:2006, IEC 61189-3:2007.

A list of all parts in the IEC 61189 series, published under the general title *Test methods for electrical materials, printed boards and other interconnection structures and assemblies*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

## INTRODUCTION

IEC 61189 relates to test methods for materials or component robustness for printed board assemblies, irrespective of their method of manufacture.

The standard is divided into separate parts, covering information for the designer and the test methodology engineer or technician. Each part has a specific focus; methods are grouped according to their application and numbered sequentially as they are developed and released.

In some instances test methods developed by other TCs (for example, TC 104) have been reproduced from existing IEC standards in order to provide the reader with a comprehensive set of test methods. When this situation occurs, it will be noted on the specific test method; if the test method is reproduced with minor revision, those paragraphs that are different are identified.

This part of IEC 61189 contains test methods for evaluating robustness of materials or component for printed board assemblies. The methods are self-contained, with sufficient detail and description so as to achieve uniformity and reproducibility in the procedures and test methodologies.

The tests shown in this standard are grouped according to the following principles:

- P: preparation/conditioning methods
- V: visual test methods
- D: dimensional test methods
- C: chemical test methods
- M: mechanical test methods
- E: electrical test methods
- N: environmental test methods
- X: miscellaneous test methods

To facilitate reference to the tests, to retain consistency of presentation, and to provide for future expansion, each test is identified by a number (assigned sequentially) added to the prefix (group code) letter showing the group to which the test method belongs.

The test method numbers have no significance with respect to a possible test sequence; that responsibility rests with the relevant specification that calls for the method being performed. The relevant specification, in most instances, also describes pass/fail criteria.

The letter and number combinations are for reference purposes to be used by the relevant specification. Thus "5-4C01" represents the first chemical test method described in IEC 61189-5-4.

In short, in this example, 5-4 is the number of the part of IEC 61189, C is the group of methods, and 01 is the test number.

## **TEST METHODS FOR ELECTRICAL MATERIALS, PRINTED BOARDS AND OTHER INTERCONNECTION STRUCTURES AND ASSEMBLIES –**

### **Part 5-4: General test methods for materials and assemblies – Solder alloys and fluxed and non-fluxed solid wire for printed board assemblies**

#### **1 Scope**

This part of IEC 61189 is a catalogue of test methods representing methodologies and procedures that can be applied to test printed board assemblies.

This part of IEC 61189 focuses on test methods for solder alloys, fluxed and non-fluxed solid wire, based on existing IEC 61189-5 and IEC 61189-6. In addition, it includes test methods for solder alloys, fluxed and non-fluxed solid wire, and for lead free soldering.

#### **2 Normative references**

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61189-5, *Test methods for electrical materials, interconnection structures and assemblies – Part 5: Test methods for printed board assemblies*

IEC 61189-6, *Test methods for electrical materials, interconnection structures and assemblies – Part 6: Test methods for materials used in manufacturing electronic assemblies*

IEC 61190-1-3, *Attachment materials for electronic assembly – Part 1-3: Requirements for electronic grade solder alloys and fluxed and non-fluxed solid solders for electronic soldering applications*

koniec náhľadu – text d'alej pokračuje v platenej verzii STN